

Notice of References Cited	Application/Control No. 10/807,394	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner D. Rutledge	Art Unit 2851	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,168,296	12-1992	Nakamura et al.	396/620
	B	US-5,379,087	01-1995	Devaney et al.	396/636
	C	US-6,071,020	06-2000	Verlinden et al.	396/612
	D	US-6,652,168	11-2003	Hyodo, Tomoyoshi	396/620
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
	O					
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NON-PATENT DOCUMENTS

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	V	
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